


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574219	<b>Applicant(s)/Patent Under Reexamination</b>  SCHULZ ET AL.
	<b>Examiner</b>  Luke Karpinski	<b>Art Unit</b>  1616

SEARCHED			
Class	Subclass	Date	Examiner
424	65, 68, 400, 401	3/2008	SAD

SEARCH NOTES		
Search Notes	Date	Examiner
INVENTOR SEARCH	3/2008	SAD
STN	3/2008	SAD
EAST and PALM inventor name search	2/25/2009	LEK
EAST (all db's) see attached search history	2/25/2009, 2/26/2009	LEK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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